U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  OF REFERENCES CITED BY APPLICANT(S)  (Use several sheets if necessary)	ATTY DOCKET NO. APPLICATION NO. 10/54			
	APPLICANT SHUNICHI ISHIHARA			
	371(c) DATE September 20, 2005	GROUP		

September 20, 2005 1753

TRACE			U.S. PATENT DOCUMENTS			
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/X.T./	6,653,554	11/25/03	Ishihara	136	258	
/X.T./	6,387,780	05/14/02	Nishida	438	497	
/X.T./	5,246,886	09/21/93	Sakai, et al.	437	228	
/X.T./	2006/0194417	08/31/06	Ishihara, et al.	438	479	
/X.T./	2005/0136576	06/23/05	Ishihara, et al.	438	162	
/X.T./	2005/0066881	03/31/05	Nakagawa, et al.	117	18	
		FC	DREIGN PATENT DOCUMENTS	T	<del></del>	
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/X.T./	2965094	08/13/99	Japan			Abstract
/X.T./	10-98205	04/14/98	Japan			Abstract
/X.T./	8-250433	09/27/96	Japan			Abstract
/X.T./	5-48128	02/26/93	Japan	-		Abstract
		TUE DOC: 11 TO TO		A Roma State		
/X.T./	Haruo Itoh, et a	I., "Characte	(Including Author, Title, Date, Pertiner rization of Silicon Layers stalline Substrates", Jou	Epitaxially Gr		. 45, 1978,
/X.T./	cells", Solar En		of silicon thin layers on c ls and Solar Cells, Vol. 4	1/42, 1996, pp.	19-30.	ions for sola
XAMINER	/Xiuyu Tai/		DATE CONSIDERED	03/13/2008		

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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